CERTIFICATE NO.: TS[illegible]

LICENCE HOLDER:

GigaDevice Semiconductor Inc.
101, 1ST TO 5TH FLOOR, BUILDING 8, NO. 9
FENGTAI EAST ROAD, FENGTAI DISTRICT, 100070
BEIJING, P.R.CHINA

Project No.:	LICENSED TEST MARK	Report No.:
V1TL	SGS TÜV SAAR ASIL D READY Functional Safety www.sgs-tuev-saar.com	V1TL0001

Tested according to: ISO 26262-5:2018 (Clauses 8 and 9)

Certified Product: GD32H75E and GD32H77E Product Family

Technical Data/Parameter:
The above-mentioned product has been approved based on the safety assessment of a reference configuration (see certification report for details).
The architectural metrics SPFM (Single-point fault metric) and LFM (Latent fault metric), as well as the estimated PMHF (Probabilistic Metric for random Hardware Failures) are in conformance with ASIL D target values.

Specific Requirements:
The certificate is only approved based on a valid functional safety assessment. Any changes to the design, materials, components or processing may require re-approval of some or the reassessment and order to retain approval.
The certificate report is an integral part of this certificate. All requirements and specifications of the current valid revision of this report shall be met.

Certification Body for Functional Safety
SGS-TÜV Saar GmbH

Puchheim, Nov 05, 2024

Marcus Rau

The validation status is documented via SGS Certification Database.

The test mark regulation is an integral part of this certificate.

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